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## 1.0 **ENGINEERING TEST REPORT**

j. Power Supply

5. Date of Measurement

This is to certify that the Household use Microwave Oven/Model NN-MX25WF, from which the following data has been derived complies with the requirements of "FCC Rules and Regulations Part 18 Subpart C"as of the date the measurements were made.

Any modification to the unit as tested may invalidate the data and void this certification.

- 1. Applicant : Matsushita Technology Corporation of America
- Address : 9333 West Grand Avenue, Franklin Park, Illinois 60131 U.S.A.
- 2. Manufacturer Shanghai Matsushita Microwave Oven Company Ltd.

: 120V AC 60Hz

: October 31, 2001

- Address 898 Long Dong Road, Shanghai 201203 China
- 3. Description of Appliance a. Name of Appliance : Household use Microwave Oven
  - b. Equipment authorization : Certification c. FCC ID. : ACLAP5G41
- d. Model No. : NN-MX25WF e. Serial No. : PP001
- f. Date of Manufacture : August, 2001 g. Oscillating Frequency : Clock of Controller : 8MHz
- h. Operating Frequency : 2450MHz i. Highest Frequency : 2450MHz
- 4. Measurement Site Matsushita EMC Center

- 6. Summary of Mesurement Results
  - a. Radiated Emission : minimum Limit Margin 15.38 uV/m(AV) at 2400.00 MHz
  - b. Safety Check of Leakage : Less than the limit of 0.5 mW/cm<sup>2</sup>

These test results are traceable to the National and International Standards.

Measurement Uncertainty, at time of test, with at least 95% confidence, was estimated to be as follows:

Radiated Emission Measurement

: 2.6 dB

Katsuo Ishihara

Katsur-lshihara

Chief Engineer of Matsushita EMC Center

Date: November 1, 2001